

<b>Notice of References Cited</b>	Application/Control No. 10/728,480	Applicant(s)/Patent Under Reexamination FOSTER ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,527,251	07-1985	Nibby et al.	714/8
	B	US-5,715,419	02-1998	Szczepanek et al.	711/212
	C	US-6,769,046	07-2004	Adams et al.	710/316
	D	US-6,229,788	05-2001	Graves et al.	370/230
	E	US-5,956,743	09-1999	Bruce et al.	711/103
	F	US-5,721,931	02-1998	Gephardt et al.	710/260
	G	US-6,594,718	07-2003	Ebner et al.	710/240
	H	US-6,215,748	04-2001	Greenwood et al.	369/53.31
	I	US-6,052,773	04-2000	DeHon et al.	712/43
	J	US-2005/0138261	06-2005	Marushak et al.	710/316
	K	US-2005/0066100	03-2005	Elliott et al.	710/300
	L	US-2005/0117529	06-2005	Ramos-Escano et al.	370/282
	M	US-2001/0043602	11-2001	Brown, David A.	370/392

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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